United States Patent [19] 4,748,053 [11] Patent Number: May 31, 1988 Okada Date of Patent: [45] [54] METHOD OF FORMING A UNIFORM 0026214 2/1977 Japan 427/240 57-050573 3/1982 Japan 427/240 RESIST FILM BY SELECTING A DURATION OF ROTATION Primary Examiner—Janyce A. Bell [75] Inventor: Masato Okada, Tokyo, Japan Attorney, Agent, or Firm-Roberts, Spiecens & Cohen [73] Assignee: Hoya Corporation, Tokyo, Japan ABSTRACT [21] Appl. No.: 679,317 In a method of coating a substrate with a resist film, the substrate is rotated at a first speed of rotation, and a [22] Filed: Dec. 7, 1984 duration of rotation, and a multiplication product be-[30] Foreign Application Priority Data tween the first speed and the rotation in consideration of a desired thickness after a resist is dropped on the sub-Dec. 8, 1983 [JP] Japan 58-231933 strate. The resist is uniformly spread on the substrate to [51] Int. Cl.⁴ B05D 3/12 form a wide uniform area because uniformity of the [52] U.S. Cl. 427/240; 427/385.5; resist depends not only on the first speed but also on the 430/270; 430/935 duration and the multiplication product. After elapse of the duration of rotation, the spread resist is dried to 430/270, 935 form the resist film by rotating the substrate at a second [56] References Cited speed slower than the first speed. The first speed is U.S. PATENT DOCUMENTS selected between 100 (rpm) and 6,000 (rpm) while the duration and the multiplication product do not exceed 4,113,492 9/1978 Sato et al. 427/240 20 (sec) and 24,000 (rpm.sec), respectively. The second 4,267,212 5/1981 Sakawaki 427/240 speed is not faster than 130 (rpm). FOREIGN PATENT DOCUMENTS 0047999 9/1963 Japan 427/240 8 Claims, 1 Drawing Sheet